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SCDS157A-OCTOBER 2003-REVISED FEBRUARY 2005

FEATURES

- Member of the Texas Instruments Widebus™ **Family**
- Output Voltage Translation Tracks V_{CC}
- **Supports Mixed-Mode Signal Operation on All** Data I/O Ports
 - 5-V Input Down to 3.3-V Output Level Shift With 3.3-V V_{CC}
 - 5-V/3.3-V Input Down to 2.5-V Output Level Shift With 2.5-V V_{CC}
- 5-V-Tolerant I/Os With Device Powered Up or **Powered Down**
- Bidirectional Data Flow, With Near-Zero **Propagation Delay**
- Low ON-State Resistance (ron) Characteristics $(r_{on} = 5 \Omega \text{ Typ})$
- **Low Input/Output Capacitance Minimizes** Loading ($C_{io(OFF)} = 9 pF Typ$)
- **Data and Control Inputs Provide Undershoot** Clamp Diodes
- Low Power Consumption ($I_{CC} = 70 \mu A Max$)
- V_{CC} Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0-V to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- **ESD Performance Tested Per JESD 22**
 - 2000-V Human-Body Model(A114-B, Class II)
 - 1000-V Charged-Device Model (C101)
- **Supports Digital Applications: Level** Translation, PCI Interface, USB Interface, Memory Interleaving, and Bus Isolation
- Ideal for Low-Power Portable Equipment

DGG OR DGV PACKAGE (TOP VIEW)

| | | abla | | |
|-----------------|----|--------|----|--------|
| S0 | 1 | \cup | 56 |] S1 |
| 1A1 | 2 | | 55 |] S2 |
| 1A2 | 3 | | 54 |] 1B1 |
| 2A1 | 4 | | 53 |] 1B2 |
| 2A2 | 5 | | 52 |] 2B1 |
| 3A1 | 6 | | 51 |] 2B2 |
| 3A2 | 7 | | 50 |] 3B1 |
| GND | 8 | | 49 | GND |
| 4A1 | 9 | | 48 | 3B2 |
| 4A2 | 10 | | 47 |] 4B1 |
| 5A1 | 11 | | 46 |] 4B2 |
| 5A2 | 12 | | 45 |] 5B1 |
| 6A1 | 13 | | 44 |] 5B2 |
| 6A2 | 14 | | 43 |] 6B1 |
| 7A1 | 15 | | 42 |] 6B2 |
| 7A2 | 16 | | 41 |] 7B1 |
| V _{CC} | 17 | | 40 |] 7B2 |
| 8A1 | 18 | | 39 |] 8B1 |
| GND | 19 | | 38 | GND |
| 8A2 | 20 | | 37 | 8B2 |
| 9A1 | 21 | | 36 | 9B1 |
| 9A2 | 22 | | 35 |] 9B2 |
| 10A1 | 23 | | 34 |] 10B1 |
| 10A2 | 24 | | 33 | 10B2 |
| 11A1 | 25 | | 32 |] 11B1 |
| 11A2 | 26 | | 31 |] 11B2 |
| 12A1 | 27 | | 30 |] 12B1 |
| 12A2 | 28 | | 29 |] 12B2 |

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DESCRIPTION/ORDERING INFORMATION

The SN74CB3T16212 is a high-speed TTL-compatible FET bus-exchange switch, with low ON-state resistance (r_{on}), allowing for minimal propagation delay. The device fully supports mixed-mode signal operation on all data I/O ports by providing voltage translation that tracks V_{CC}. The SN74CB3T16212 supports systems using 5-V TTL, 3.3-V LVTTL, and 2.5-V CMOS switching standards, as well as user-defined switching levels (see Figure 1).

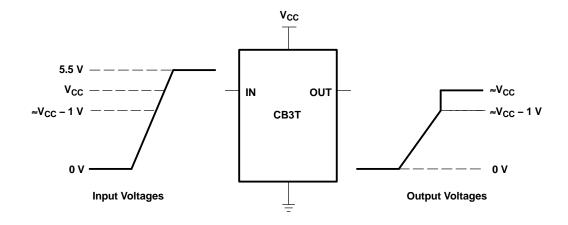
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Widebus is a trademark of Texas Instruments.

24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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NOTE: If the input high-voltage (V_{IH}) level is greater than or equal to V_{CC} – 1 V and less than or equal to 5.5 V, the output high-voltage (V_{OH}) level is equal to approximately the V_{CC} voltage level.

Figure 1. Typical DC Voltage Translation Characteristics

The SN74CB3T16212 operates as a 24-bit bus switch or as a 12-bit bus exchange that provides data exchanging between four signal ports. The select (S0, S1, S2) inputs control the data path of the bus-exchange switch. When the bus-exchange switch is ON, the A port is connected to the B port, allowing bidirectional data flow between ports. When the bus-exchange switch is OFF, a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, each select input should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

ORDERING INFORMATION

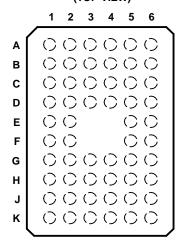
| T _A | PACKAG | 6E ⁽¹⁾ | ORDERABLE PART NUMBER | TOP-SIDE MARKING | | |
|----------------|-----------------------|-------------------|-----------------------|------------------|--|--|
| | TSSOP – DGG | Tape and reel | SN74CB3T16212DGGR | CB3T16212 | | |
| -40°C to 85°C | TVSOP - DGV | Tape and reel | SN74CB3T16212DGVR | KR212 | | |
| -40 C to 65 C | VFBGA – GQL | Tape and reel | SN74CB3T16212GQLR | - KR212 | | |
| | VFBGA – ZQL (Pb-free) | Tape and reel | SN74CB3T16212ZQLR | | | |

⁽¹⁾ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

SN74CB3T16212 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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GQL OR ZQL PACKAGE (TOP VIEW)



TERMINAL ASSIGNMENTS

| | 1 | 2 | 3 | 4 | 5 | 6 |
|---|-----------------|------|------|------|------|------|
| Α | 1A2 | 1A1 | S0 | S1 | S2 | 1B1 |
| В | 3A1 | 2A2 | 2A1 | 1B2 | 2B1 | 2B2 |
| С | 4A1 | GND | 3A2 | 3B1 | GND | 3B2 |
| D | 5A2 | 4A2 | 5A1 | 4B2 | 4B1 | 5B1 |
| Е | 6A2 | 6A1 | | | 5B2 | 6B1 |
| F | 7A1 | 7A2 | | | 7B1 | 6B2 |
| G | V _{CC} | GND | 8A1 | 8B1 | GND | 7B2 |
| Н | 8A2 | 9A1 | 9A2 | 9B2 | 9B1 | 8B2 |
| J | 10A1 | 10A2 | 11A1 | 11B1 | 10B2 | 10B1 |
| K | 11A2 | 12A1 | 12A2 | 12B2 | 12B1 | 11B2 |

FUNCTION TABLE

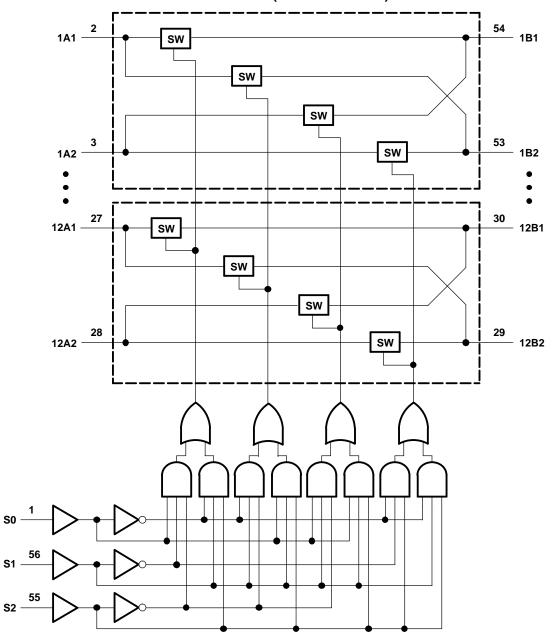
| | INPUTS | ; | INPUTS/0 | DUTPUTS | FUNCTION |
|----|--------|----|----------|---------|--|
| S2 | S1 | S0 | A1 | A2 | FUNCTION |
| L | L | L | Z | Z | Disconnect |
| L | L | Н | B1 port | Z | A1 port = B1 port |
| L | Н | L | B2 port | Z | A1 port = B2 port |
| L | Н | Н | Z | B1 port | A2 port = B1 port |
| Н | L | L | Z | B2 port | A2 port = B2 port |
| Н | L | Н | Z | Z | Disconnect |
| Н | Н | L | B1 port | B2 port | A1 port = B1 port A2 port = B2 port |
| Н | Н | Н | B2 port | B1 port | A1 port = B2 port A2 port = B1 port |

24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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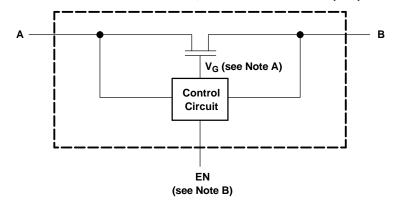
LOGIC DIAGRAM (POSITIVE LOGIC)



SN74CB3T16212 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



- A. Gate voltage (V_G) is equal to approximately $V_{CC} + V_T$ when the switch is ON and $V_I > V_{CC} + V_T$.
- B. EN is the internal enable signal applied to the switch.

ABSOLUTE MAXIMUM RATINGS(1)

over free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|-------------------|---|----------------------|------|------|------|
| V _{CC} | Supply voltage range (2) | | -0.5 | 7 | V |
| V _{IN} | Control input voltage range ⁽²⁾⁽³⁾ | -0.5 | 7 | V | |
| V _{I/O} | Switch I/O voltage range ⁽²⁾⁽³⁾⁽⁴⁾ | -0.5 | 7 | V | |
| I _{IK} | Control input clamp current | V _{IN} < 0 | | -50 | mA |
| I _{I/OK} | I/O port clamp current | V _{I/O} < 0 | | -50 | mA |
| I _{I/O} | ON-state switch current ⁽⁵⁾ | | | ±128 | mA |
| | Continuous current through V _{CC} or GND | | | ±100 | mA |
| | | DGG package | | 64 | |
| θ_{JA} | Package thermal impedance (6) | DGV package | | 48 | °C/W |
| | | GQL/ZQL package | | 42 | |
| T _{stg} | Storage temperature range | | -65 | 150 | °C |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output volrage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4) V_1 and V_0 are used to denote specific conditions for $V_{1/0}$.
- (5) I_1 and I_0 are used to denote specific conditions for $I_{1/0}$.
- (6) The package thermal impedance is calculated in accordance with JESD 51-7.

RECOMMENDED OPERATING CONDITIONS(1)

| | | | MIN | MAX | UNIT | |
|------------------|--|--|-----|-----|------|--|
| V _{CC} | Supply voltage | Supply voltage | | | | |
| ., | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ | | 1.7 | 5.5 | V | |
| V _{IH} | High-level control input voltage | $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$ | 2 | 5.5 | V | |
| \/ | Low level control input voltage | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ | | 0.7 | | |
| V_{IL} | Low-level control input voltage | V _{CC} = 2.7 V to 3.6 V | 0 | 8.0 | V | |
| V _{I/O} | Data input/output voltage | | 0 | 5.5 | V | |
| T _A | Operating free-air temperature | | -40 | 85 | °C | |

All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

SN74CB3T16212

24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER



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ELECTRICAL CHARACTERISTICS(1)

| PAR | AMETER | TEST CONDITION | S | MIN TYP ⁽²⁾ | MAX | UNIT | | | |
|--------------------------------|----------------|---|--|------------------------|-----|------|--|--|--|
| V_{IK} | | $V_{CC} = 3 \text{ V}, I_{I} = -18 \text{ mA}$ | $3 \text{ V, I}_{I} = -18 \text{ mA}$ | | | | | | |
| V_{OH} | | See Figures 3 and 4 | | | | | | | |
| I _{IN} | Control inputs | $V_{CC} = 3.6 \text{ V}, V_{IN} = 3.6 \text{ V} \text{ to } 5.5 \text{ V} \text{ or GND}$ | | | ±10 | μΑ | | | |
| | | | $V_{I} = V_{CC} - 0.7 \text{ V to } 5.5 \text{ V}$ | | ±20 | | | | |
| I_{\parallel} | | V_{CC} = 3.6 V, V_{IN} = V_{CC} or GND, Switch ON | $V_{I} = 0.7 \text{ V to } V_{CC} - 0.7 \text{ V}$ | | -40 | μΑ | | | |
| | | | $V_{I} = 0 \text{ to } 0.7 \text{ V}$ | | ±5 | | | | |
| $I_{OZ}^{(3)}$ | | $V_{CC} = 3.6 \text{ V}, V_{I} = 0, V_{IN} = V_{CC} \text{ or GND}, V_{O} = 0$ | | ±10 | μΑ | | | | |
| I _{off} | | $V_{CC} = 0$, $V_I = 0$, $V_O = 0$ to 5.5 V | | 10 | μΑ | | | | |
| I _{CC} | | $V_{CC} = 3.6 \text{ V}, V_{IN} = V_{CC} \text{ or GND}, I_{I/O} = 0,$ | $V_I = V_{CC}$ or GND | | 70 | μА | | | |
| | | Switch ON or OFF | V _I = 5.5 V | | 70 | | | | |
| $\Delta I_{CC}^{(4)}$ | Control inputs | V_{CC} = 3 V to 3.6 V, One input at V_{CC} – 0.6 V, C | Other inputs at V _{CC} or GND | | 300 | μΑ | | | |
| C _{in} | Control inputs | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND}$ | | 4 | | pF | | | |
| C _{io(OFF)} |) | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND}, V_{I/O} = 5.5 \text{ V}, 3$ | .3 V, or GND, Switch OFF | 9 | | pF | | | |
| _ | | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND, Switch ON}$ | $V_{I/O} = 5.5 \text{ V or } 3.3 \text{ V}$ | 8 | | ~F | | | |
| C _{io(ON)} | | VCC = 5.5 V, VIN = VCC OF GIVE, SWITCH ON | $V_{I/O} = GND$ | 23 | | pF | | | |
| | | V = 2.3 V TVP at V = 2.5 V V = 0 | I _O = 24 mA | 5 | 9.5 | Ω | | | |
| r (5) | | $V_{CC} = 2.3 \text{ V}$, TYP at $V_{CC} = 2.5 \text{ V}$, $V_{I} = 0$ | I _O = 16 mA | 5 | 9.5 | | | | |
| r _{ON} ⁽⁵⁾ | | $V_{CC} = 3 \text{ V}, \text{ V}_{I} = 0$ | I _O = 64 mA | 5 | 8.5 | | | | |
| | | V _{CC} = 3 v, v _I = 0 | I _O = 32 mA | 5 | 8.5 | | | | |

- V_{IN} and I_{IN} refer to control inputs. V_I , V_O , I_I , and I_O refer to data pins. All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C.
- For I/O ports, the parameter I_{OZ} includes the input leakage current.
- This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.
- Measured by the voltage drop between A and B terminals at the indicated current throught the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

SWITCHING CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted) (see Figure 2)

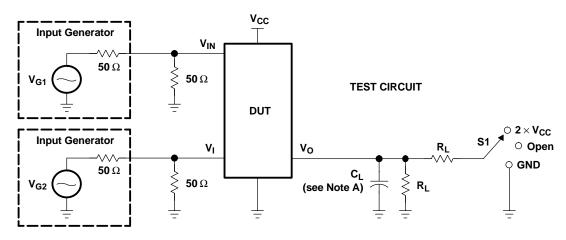
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 1 ± 0.2 | | V _{CC} = : ± 0.3 | UNIT | |
|--------------------------------|-----------------|----------------|------------------------------|------|------------------------------|------|----|
| | (INPUT) | (OUTPUT) | MIN | MAX | MIN | MAX | |
| t _{pd} ⁽¹⁾ | A or B | B or A | | 0.15 | | 0.25 | ns |
| t _{pd(s)} | S | A | 1 | 15.5 | 1 | 11.5 | ns |
| t _{en} | S | В | 1 | 15 | 1 | 12 | ns |
| t _{dis} | S | В | 1 | 12 | 1 | 10.5 | ns |

(1) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capaitance, when driven by an ideal voltage source (zero output impedance).

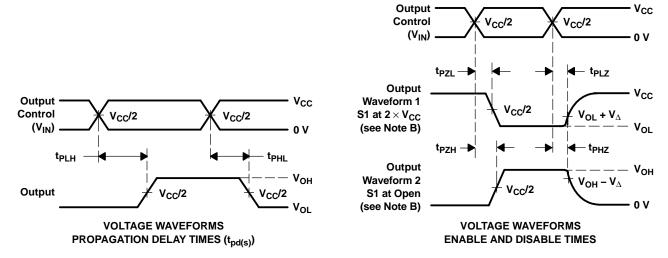
24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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PARAMETER MEASUREMENT INFORMATION



| TEST | V _{CC} | S1 | R _L | VI | CL | V_{Δ} |
|------------------------------------|-------------------|-------------------|----------------|--------------|-------|--------------|
| t _{pd(s)} | 2.5 V \pm 0.2 V | Open | 500 Ω | 3.6 V or GND | 30 pF | |
| -pu(s) | 3.3 V \pm 0.3 V | Open | 500 Ω | 5.5 V or GND | 50 pF | |
| t _{PLZ} /t _{PZL} | 2.5 V \pm 0.2 V | 2×V _{CC} | 500 Ω | GND | 30 pF | 0.15 V |
| TPLZ/TPZL | 3.3 V \pm 0.3 V | $2 \times V_{CC}$ | 500 Ω | GND | 50 pF | 0.3 V |
| 4 /4 | 2.5 V ± 0.2 V | Open | 500 Ω | 3.6 V | 30 pF | 0.15 V |
| t _{PHZ} /t _{PZH} | 3.3 V \pm 0.3 V | Open | 500 Ω | 5.5 V | 50 pF | 0.3 V |



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tpLH and tpHL are the same as tod(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 2. Test Circuit and Voltage Waveforms



TYPICAL CHARACTERISTICS

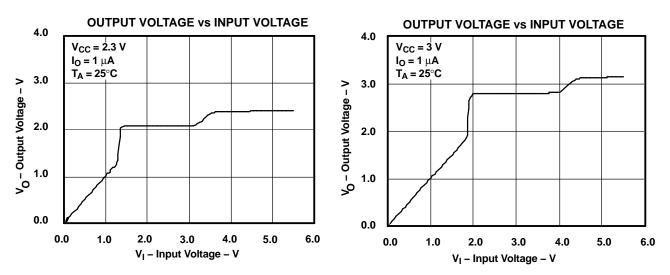
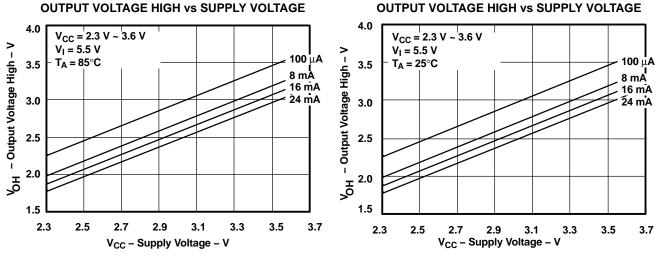


Figure 3. Data Output Voltage vs Data Input Voltage



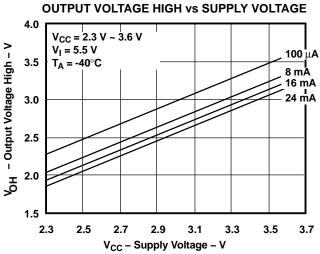


Figure 4. V_{OH} Values

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PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead finish/ Ball material | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|-------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|--------------------|--------------|----------------------|---------|
| SN74CB3T16212DGGR | ACTIVE | TSSOP | DGG | 56 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | CB3T16212 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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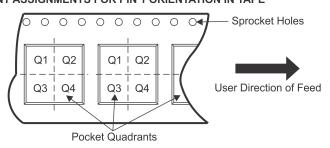
TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width |
|----|---|
| | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74CB3T16212DGGR | TSSOP | DGG | 56 | 2000 | 330.0 | 24.4 | 8.6 | 15.6 | 1.8 | 12.0 | 24.0 | Q1 |

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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74CB3T16212DGGR | TSSOP | DGG | 56 | 2000 | 367.0 | 367.0 | 45.0 |



SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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